

Notice of References Cited	Application/Control No. 10/760,538		Applicant(s)/Patent Under Reexamination YOUN, JEONG CHAE	
	Examiner MUHAMMAD N. EDUN		Art Unit 2627	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,922,802	07-2005	Kim et al.	714/723
*	B	US-2005/0022053	01-2005	Park et al.	714/007
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	M	US-			

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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